				=-	·		Reexamina	Applicant(s)/Patent Under Reexamination ARIDOR ET AL.	
Notice of References Cited					Examiner		Art Unit	<del></del>	
					Hanh B. Thai		2163	Page 1 of 1	
				U.S. P	ATENT DOCU	· · · · · · · · · · · · · · · · · · ·			
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name				Classification	
*	Α	US-6,519,586 B2	02-2003	Anick	et al.		707/3		
	В	US-							
	С	US-							
	D	US-	-						
	Е	US-							
	F	US-							
	G	US-							
	Н	US-							
	ı	US-							
	J	US-			-				
	Κ	US-							
	L	US-							
	M	US-				•			
FOREIGN PATENT DOCUMENTS									
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country Name			Classification		
	N								
	0								
	Р		,						
	Q								
	R								
	S								
	Т	·				·			
NON-PATENT DOCUMENTS									
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	Ų								
	v							·	
							,		
	·								
	w								

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х